



# Vishay Siliconix

# N-Channel 30-V (D-S) MOSFET

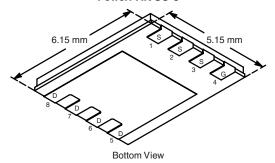
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
30	0.0047 at V <sub>GS</sub> = 10 V	40 <sup>g</sup>	16.8 nC	
	0.0061 at V <sub>GS</sub> = 4.5 V	40 <sup>g</sup>	10.6110	

### **FEATURES**

- Halogen-free According to IEC 61249-2-21
- TrenchFET® Gen III Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % Avalanche Tested



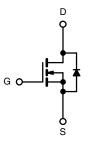




 $\textbf{Ordering Information:} \ SiR460DP-T1-GE3 \ (Lead \ (Pb)-free \ and \ Halogen-free)$ 

### **APPLICATIONS**

- Notebook Vcore
- DC/DC



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	$V_{DS}$	30	V		
Gate-Source Voltage		$V_{GS}$	± 20	v	
	T <sub>C</sub> = 25 °C		40 <sup>g</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I_	40 <sup>g</sup>	7	
Continuous Drain Current (1 <sub>J</sub> = 150°C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	24.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		19.4 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	70	^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>-</sub>	40 <sup>g</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.5 <sup>b, c</sup>	1	
Single Pulse Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	30		
Single Pulse Avalanche Energy  L = 0.1 mH		E <sub>AS</sub>	45	mJ	
	T <sub>C</sub> = 25 °C		48		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	31	w	
	T <sub>A</sub> = 25 °C	LD	5.0 <sup>b, c</sup>	- vv	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur	Ü	260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	2.1	2.6	- O/VV	

### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. See Solder Profile (<a href="https://www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- www.DataSrequired to ensure adequate bottom side solder interconnection.

  e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
  - f. Maximum under Steady State conditions is 65 °C/W.
  - g. Package Limited.

# SiR460DP

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<b>SPECIFICATIONS</b> $T_J = 25  ^{\circ}\text{C}$ Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Syllibol	rest Conditions	IVIIII.	Typ.	IVIAX.	Oilit	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_{D} = 250  \mu\text{A}$	30	I		Ιv	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	V <sub>GS</sub> = υ ν, ι <sub>D</sub> = 250 μΑ		29		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.5			
	` '	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1.0	- 5.5	0.4		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ $V_{DS} = 0  \text{V}, V_{GS} = \pm 20  \text{V}$	1.0		2.4		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
_		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		0.0038	0.0047	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		0.0049	0.0061		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A		60		S	
Dynamic <sup>b</sup>						•	
Input Capacitance	C <sub>iss</sub>			2071		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		406			
Reverse Transfer Capacitance	C <sub>rss</sub>			168			
Total Gate Charge		V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		36	54	nC	
Total date offarge	$Q_g$			16.8	25.5		
Gate-Source Charge	$Q_{gs}$ $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D =$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		5.1			
Gate-Drain Charge	$Q_{gd}$			5.2			
Gate Resistance	$R_g$	f = 1 MHz	0.2	0.85	1.7	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			25	45		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.5 $\Omega$ $I_D \cong$ 10 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		16	30	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			28	50		
Fall Time	t <sub>f</sub>			12	24		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15 V, R <sub>L</sub> = 1.5 Ω		10	20		
Rise Time	t <sub>r</sub>			9	18		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 10 \text{ A}, V_{GEN}=4.5 \text{ V}, R_g=1 \Omega$		25	45		
Fall Time	t <sub>f</sub>			9	18		
Drain-Source Body Diode Characterist	tics			<u>'</u>	<u>'</u>		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			40		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				70	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 3 A		0.73	1.1	V	
Body Diode Reverse Recovery Time				19	38	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		10	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			10		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			9			

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

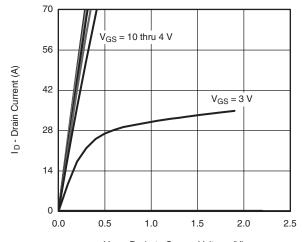
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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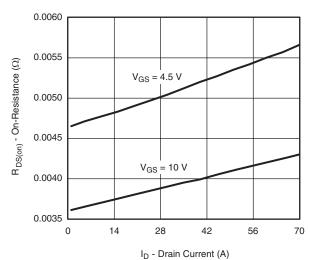
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

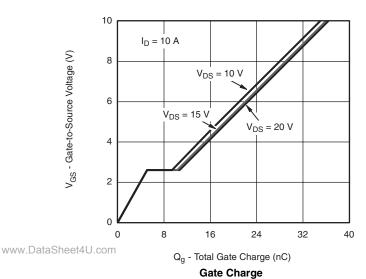


 $V_{\mbox{\scriptsize DS}}$  - Drain-to-Source Voltage (V)

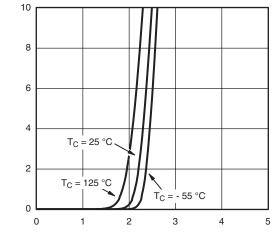
### **Output Characteristics**



On-Resistance vs. Drain Current and Gate Voltage

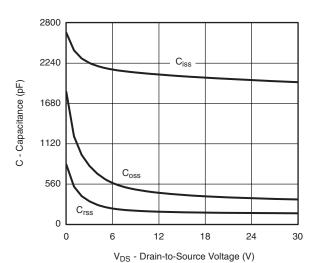


I<sub>D</sub> - Drain Current (A)

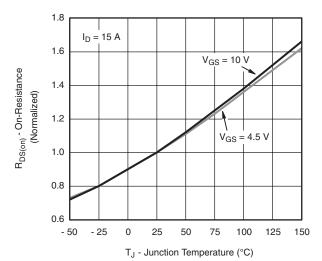


V<sub>GS</sub> - Gate-to-Source Voltage (V)

### **Transfer Characteristics**



Capacitance



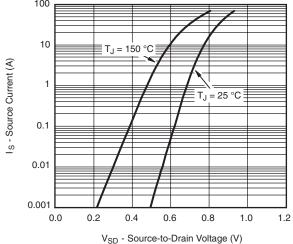
On-Resistance vs. Junction Temperature

# SiR460DP

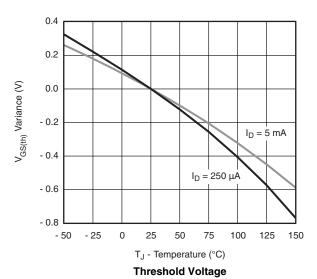
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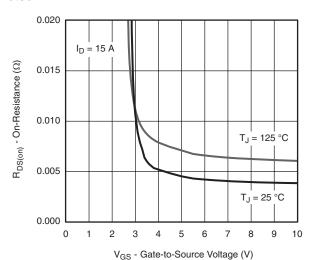
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

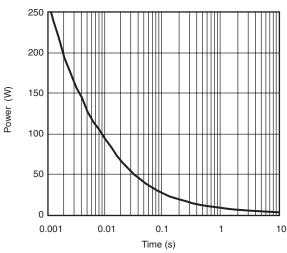


### Source-Drain Diode Forward Voltage

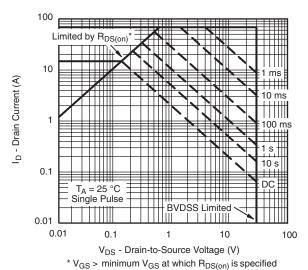




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



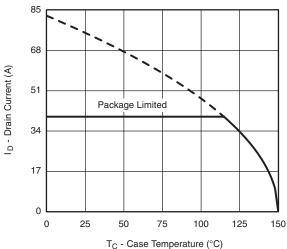
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Safe Operating Area, Junction-to-Ambient



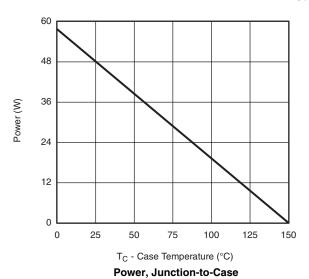
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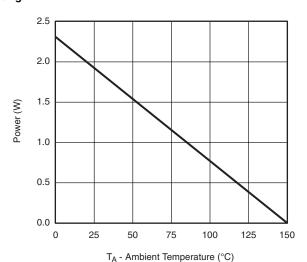
### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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### **Current Derating\***





Power, Junction-to-Ambient

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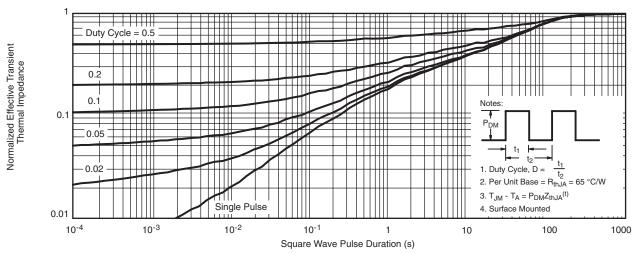
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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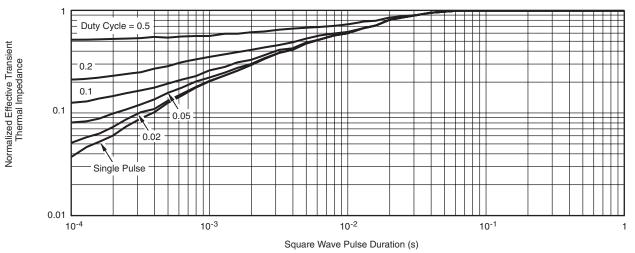
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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